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|-----------------------------------|--|-------------------------|--|---------------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination 10/596,141 JANSEN ET AL. | |
| | | Examiner | Art Unit ABDULLAH AL KAWSAR | 2195 Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-4,967,353 A | 10-1990 | Brenner et al. | 711/160 |
| * | B | US-5,179,702 A | 01-1993 | Spix et al. | 718/102 |
| * | C | US-5,423,017 A | 06-1995 | Parikh, Shrikant N. | 711/167 |
| * | D | US-5,517,643 A | 05-1996 | Davy, William | 718/105 |
| * | E | US-5,555,399 A | 09-1996 | Waldron et al. | 711/159 |
| * | F | US-5,588,135 A | 12-1996 | Tanaka, Takehiko | 711/160 |
| * | G | US-6,038,571 A | 03-2000 | Numajiri et al. | 1/1 |
| * | H | US-6,128,714 A | 10-2000 | Onodera, Osamu | 711/165 |
| * | I | US-6,167,490 A | 12-2000 | Levy et al. | 711/148 |
| * | J | US-6,199,145 B1 | 03-2001 | Ajanovic et al. | 711/149 |
| * | K | US-6,347,364 B1 | 02-2002 | Liedtke, Jochen | 711/163 |
| * | L | US-6,938,254 B1 | 08-2005 | Mathur et al. | 718/104 |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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